# CS/B.Tech (ECE-NEW) (Supple)/SEM-7/EC-702(N)/09 EDA FOR VLSI DESIGN (SEMESTER - 7)

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1.	Signature of Invigilator				Œ.	9@ Ule _^_	3/		- 2	· ·	
2.	Reg. No. Signature of the Officer-in-Charge										
	Roll No. of the Candidate										
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CS/B.Tech (ECE-NEW) (Supple)/SEM-7/EC-702(N)/09 ENGINEERING & MANAGEMENT EXAMINATIONS, JULY - 2009 EDA FOR VLSI DESIGN (SEMESTER - 7)

Time: 3 Hours [Full Marks: 70

## **INSTRUCTIONS TO THE CANDIDATES:**

- 1. This Booklet is a Question-cum-Answer Booklet. The Booklet consists of **32 pages**. The questions of this concerned subject commence from Page No. 3.
- 2. a) In **Group A**, Questions are of Multiple Choice type. You have to write the correct choice in the box provided **against each question**.
  - b) For **Groups B** & **C** you have to answer the questions in the space provided marked 'Answer Sheet'. Questions of **Group B** are Short answer type. Questions of **Group C** are Long answer type. Write on both sides of the paper.
- 3. **Fill in your Roll No. in the box** provided as in your Admit Card before answering the questions.
- 4. Read the instructions given inside carefully before answering.
- 5. You should not forget to write the corresponding question numbers while answering.
- 6. Do not write your name or put any special mark in the booklet that may disclose your identity, which will render you liable to disqualification. Any candidate found copying will be subject to Disciplinary Action under the relevant rules.
- 7. Use of Mobile Phone and Programmable Calculator is totally prohibited in the examination hall.
- 8. You should return the booklet to the invigilator at the end of the examination and should not take any page of this booklet with you outside the examination hall, **which will lead to disqualification**.
- 9. Rough work, if necessary is to be done in this booklet only and cross it through.

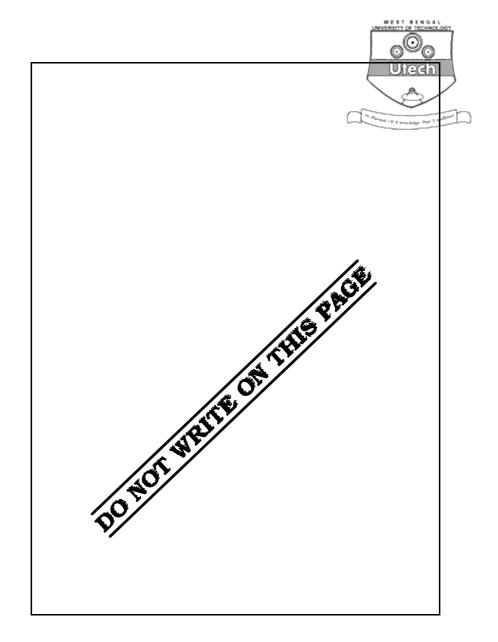
No additional sheets are to be used and no loose paper will be provided

# FOR OFFICE USE / EVALUATION ONLY Marks Obtained Group - A Group - B Group - C Question Number Marks Obtained Signature

Head-Examiner/Co-Ordinator/Scrutineer

S-53034 (29/07) (N)







# CS/B.Tech (ECE-NEW) (Supple)/SEM-7/EC-702(N)/09 EDA FOR VLSI DESIGN

SEMESTER - 7

Time: 3 Hours] [Full Marks: 70

# **GROUP - A**

			( Multiple Choice	Type ©	uestions )			
1.	Choo	hoose the correct alternatives for any <i>ten</i> of the following :						
	i)	'EDA	A' stands for					
		a)	Electronic Device Automation					
		b)	Electrical Design Automation					
		c)	Electronic Design Automation					
		d)	Electrical Device Automation.					
	ii)	Whi	ch of the following is not a part	of FPG	A cell ?			
		a)	Logic Module	b)	IOB			
		c)	Interconnect	d)	Product Term Array.			
	iii)							
		a)	slower	b)	faster			
		c)	less efficient in area	d)	none of these.			

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- iv) "ISR" stands for
  - a) In Service Resource
  - b) Input System Reprogram
  - c) Input System Reprogrammability
  - d) In System Reprogrammability.



- a) 1 programmable plane
- b) 2 programmable planes
- c) 1 fixed and 1 programmable planes
- d) 2 fixed planes.
- vi) VHDL stands for
  - a) Verilog Hardware Description Language
  - b) Very High Speed Integrated Circuit Hardware Description Language

4

- c) Valid Hardware Description Language
- d) Very High Speed Integrated Circuit Hardware Display Language.
- vii) The steps of implementation of FPGA must be carried out in the order
  - a) Synthesize Place & Route Map Timing Simulate Program
  - b) Synthesize Map Place & Route Timing Simulate Program
  - c) Program Synthesize Place & Route Timing Simulate Map
  - d) Program Map Place & Route Timing Simulate Synthesize.

c)

d)

Datapath and Control synthesis

Logic Level Synthesis.



xiii)	PAL	has
XIIII	PAL	Has

xiv)

d)

Low C.

1111		<u> </u>	
a)	Fixed OR gate plane	Utech	
b)	Fixed AND gate plane	N a woody 2nd 1	
c)	Both planes that are fixed		
d)	Both planes that are programmable.		
СМО	OS diffusion layers have		
a)	Moderate IR drop but low C		
b)	Low IR drop but high C		
c)	High IR drop		

- xv) Regularity of a VLSI circuit is defined as
  - a) total no. of transistor on the chip/no. of transistor circuits that must be designed in detail
  - b) no. of transistor circuits that must be designed in detail/total no. of transistor on the chip
  - c) total no. of transistor on the chip/total chip area
  - d) none of these.



# **GROUP - B**

# ( Short Answer Type Questions )

Answer any *three* of the following.



 $3 \propto 5 = 15$ 

- 2. What are the differences between FPGA and CPLD in terms of architecture and feature ?
- 3. What are slice, CLB, LUT? Is it possible to configure CLB as RAM?
- 4. Define 'package' and 'architecture' in VHDL. Write a VHDL code for tri-state buffer.

2 + 3

- 5. Explain the BIST techniques.
- 6. What are the several factors to improve propagation delay of standard cell?

# **GROUP - C**

# (Long Answer Type Questions)

Answer any *three* of the following.

 $3 \propto 15 = 45$ 

- 7. a) What do you mean by test and testability of VLSI systems?
  - b) Define controllability and observability of VLSI circuits.
  - c) Explain the D-algorithm for combinational logic.
  - d) What do you mean by sensitized path based testing?

4 + 4 + 4 + 3

- 8. a) Define physical design.
  - b) Mention the need of physical design in VLSI.
  - c) Explain the various steps of physical design.
  - d) What is standard cell design? How does it differ from gate-array design?

2 + 2 + 6 + 2 + 3



- 9. a) What is FPGA?
  - b) Compare Antifuse FPGA and SRAM based FPGA.
  - c) With diagram, explain the architecture of SRAM based FR
  - d) What is JTAG?
  - e) Write down the differences between CPLD and FPGA.

2 + 3 + 5 + 2 + 3

10. a) Write a VHDL code for LONG\_WAY\_SHIFTER given in the following figure.

Dia.

- b) Write a VHDL code for 4:1 MUX using PROCESS.
- c) What are the differences between 'If statement' and 'case statement' in VHDL?

8 + 4 + 3

11. Write short notes on any three of the following:

 $3 \propto 5$ 

- a) Floor planning
- b) Application specific integrated circuits
- c) Test generation
- d) Analog Design automation tools
- e) Optimization of Combinational circuits.

**END**